



# GANB1R2-040QBA

40 V, 1.2 mOhm bi-directional Gallium Nitride (GaN) FET  
in a 4.0 mm x 6.0 mm Very-Thin-Profile Quad Flat No-Lead  
Package (VQFN)

12 March 2025

Product data sheet

## 1. General description

The GANB1R2-040QBA is a 40 V, 1.2 m $\Omega$  bi-directional Gallium Nitride (GaN) High Electron-Mobility-Transistor (HEMT) in a Very-Thin-Profile Quad Flat No-Lead Package (VQFN) package. It is a normally-off e-mode device offering superior performance and very low on-state resistance.

## 2. Features and benefits

- Enhancement mode - normally-off power switch
- Bi-directional device
- Ultra high switching speed capability
- Ultra-low on-state resistance
- RoHS, Pb-free, REACH-compliant
- High efficiency and high power density
- Very-Thin-Profile Quad Flat No-Lead Package (VQFN) 4.0 mm x 6.0 mm

## 3. Applications

- High-side load switch
- OVP protection in smart phone USB port
- Power switch circuits
- Stand-by power system

## 4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
V <sub>DD</sub>	drain-drain voltage	-40 °C ≤ T <sub>j</sub> ≤ 125 °C	[1]	-	-	40	V
I <sub>D</sub>	drain current	T <sub>mb</sub> ≤ 25 °C	[2]	-	-	100	A
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <a href="#">Fig. 1</a>		-	-	105	W
T <sub>j</sub>	junction temperature			-40	-	125	°C
Static characteristics							
R <sub>DDon</sub>	drain-drain on-state resistance	V <sub>GD2</sub> = 5 V; V; I <sub>D1</sub> = 10 A; T <sub>j</sub> = 25 °C; <a href="#">Fig. 9</a> ; <a href="#">Fig. 10</a> ; <a href="#">Fig. 11</a>	[1]	-	0.9	1.2	mΩ
		V <sub>GD2</sub> = 5 V; V; I <sub>D1</sub> = 10 A; T <sub>j</sub> = 125 °C; <a href="#">Fig. 9</a> ; <a href="#">Fig. 12</a>	[1]	-	1.6	-	mΩ
Dynamic characteristics							
Q <sub>G(tot)</sub>	total gate charge	I <sub>D</sub> = 10 A; V <sub>DS</sub> = 20 V; V <sub>GS</sub> = 5 V; T <sub>j</sub> = 25 °C; <a href="#">Fig. 13</a> ; <a href="#">Fig. 14</a>	[2]	-	60	-	nC

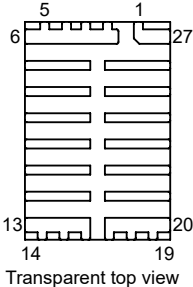
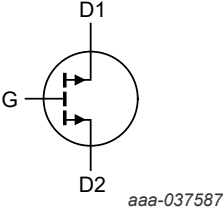
[1] This parameter applies for either polarity of bias; it is the same whether D1 is the source and D2 is the drain, or vice versa.

[2] D1 and D2 are symmetrical with respect to the gate, G. Either can take the function of source or drain. For data sheet parameters, the source is defined as the terminal, D1 or D2, which has lower potential in the test circuit. The drain is the terminal with the higher potential.

40 V, 1.2 mOhm bi-directional Gallium Nitride (GaN) FET in a 4.0 mm x 6.0 mm Very-Thin-Profile Quad Flat No-Lead Package (VQFN)

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1, 27	G	gate	 Transparent top view SOT8092-1	 aaa-037587
2 - 6, 8, 10, 12, 21, 23, 25	D1	drain1		
7, 9, 11, 13 - 20, 22, 24, 26	D2	drain2		

6. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
<a href="#">GANB1R2-040QBA</a>	VQFN16	very thin quad flatpack; no leads; 6 mm x 4 mm x 0.85 mm body	<a href="#">SOT8092-1</a>

7. Marking

Table 4. Marking codes

Type number	Marking code
GANB1R2-040QBA	1R2AQBA

40 V, 1.2 mOhm bi-directional Gallium Nitride (GaN) FET in a 4.0 mm x 6.0 mm Very-Thin-Profile Quad Flat No-Lead Package (VQFN)

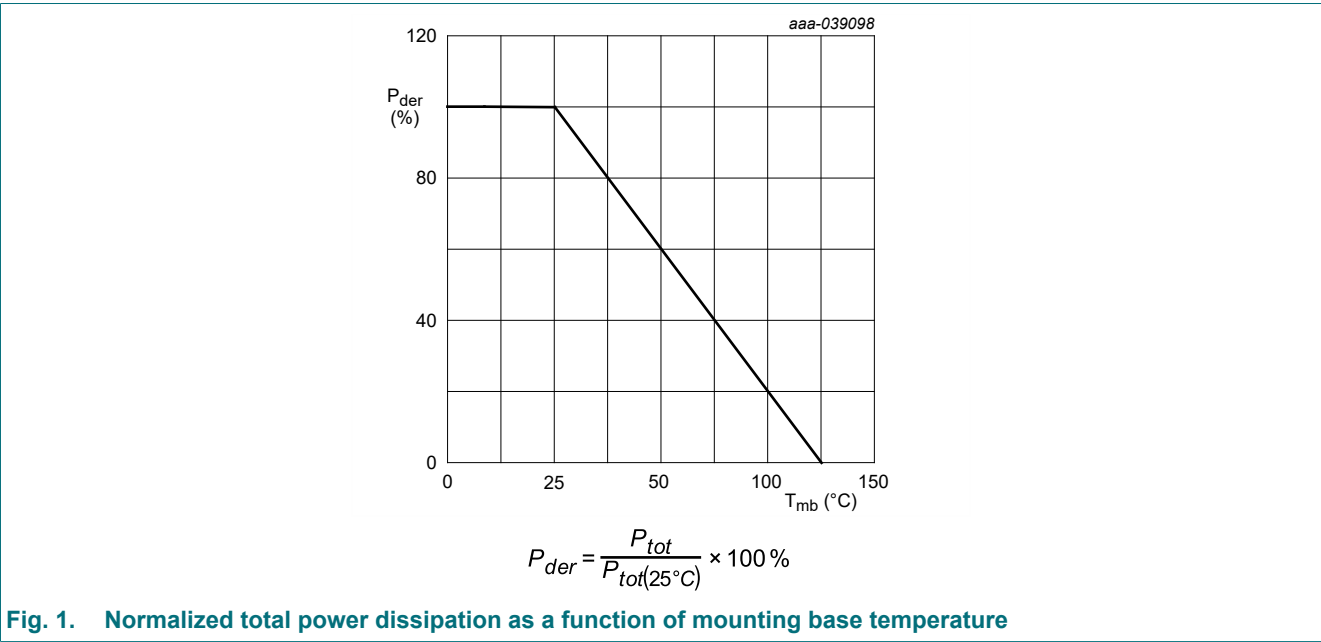
8. Limiting values

Table 5. Limiting values

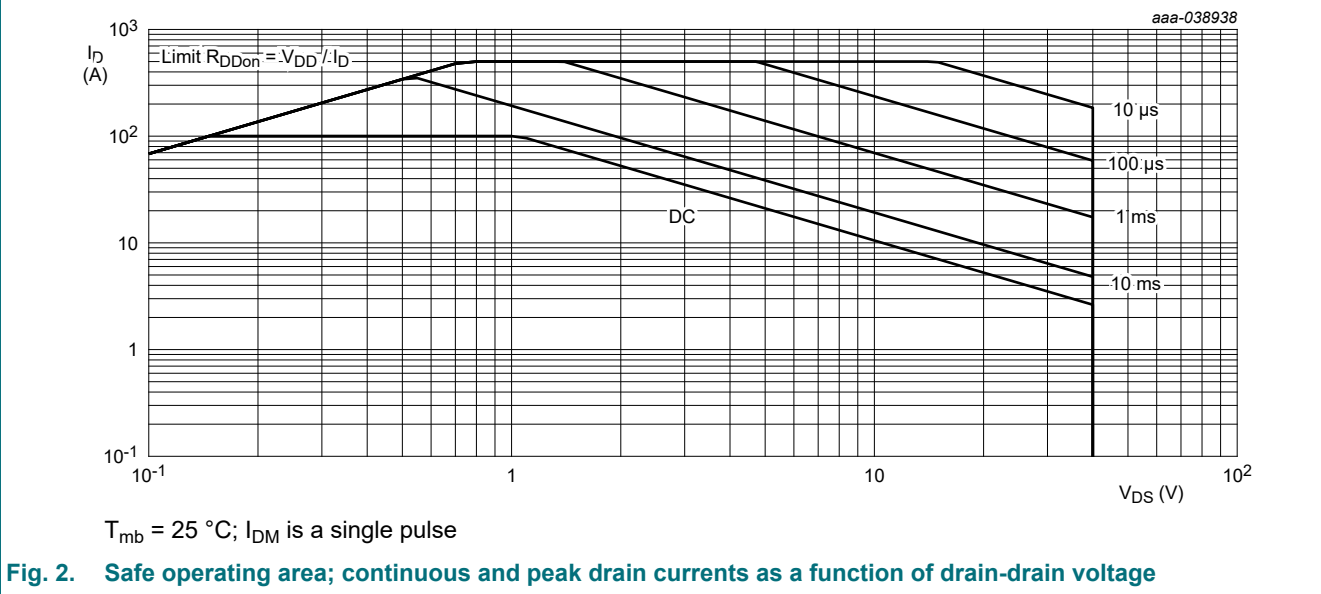
In accordance with the Absolute Maximum Rating System (IEC 60134). Tj = 25 °C unless otherwise stated.

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>DD</sub>	drain-drain voltage	-40 °C ≤ T <sub>j</sub> ≤ 125 °C	[1]	-	40	V
V <sub>DG</sub>	drain-gate voltage		[2]	-	40	V
V <sub>GD</sub>	gate-drain voltage		[2]	-	6	V
I <sub>D</sub>	drain current	V <sub>GD</sub> = 5 V; T <sub>mb</sub> = 25 °C	[2]	-	100	A
I <sub>DM</sub>	peak drain current	pulsed; t <sub>p</sub> ≤ 300 μs; T <sub>mb</sub> = 25 °C; Fig. 2	[2]	-	500	A
P <sub>(tot)</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; Fig. 1		-	105	W
T <sub>stg</sub>	storage temperature			-40	150	°C
T <sub>j</sub>	junction temperature			-40	125	°C
T <sub>sld(M)</sub>	peak soldering temperature			-	260	°C

- [1] This parameter applies for either polarity of bias; it is the same whether D1 is the source and D2 is the drain, or vice versa.
- [2] D1 and D2 are symmetrical with respect to the gate, G. Either can take the function of source or drain. For data sheet parameters, the source is defined as the terminal, D1 or D2, which has lower potential in the test circuit. The drain is the terminal with the higher potential.



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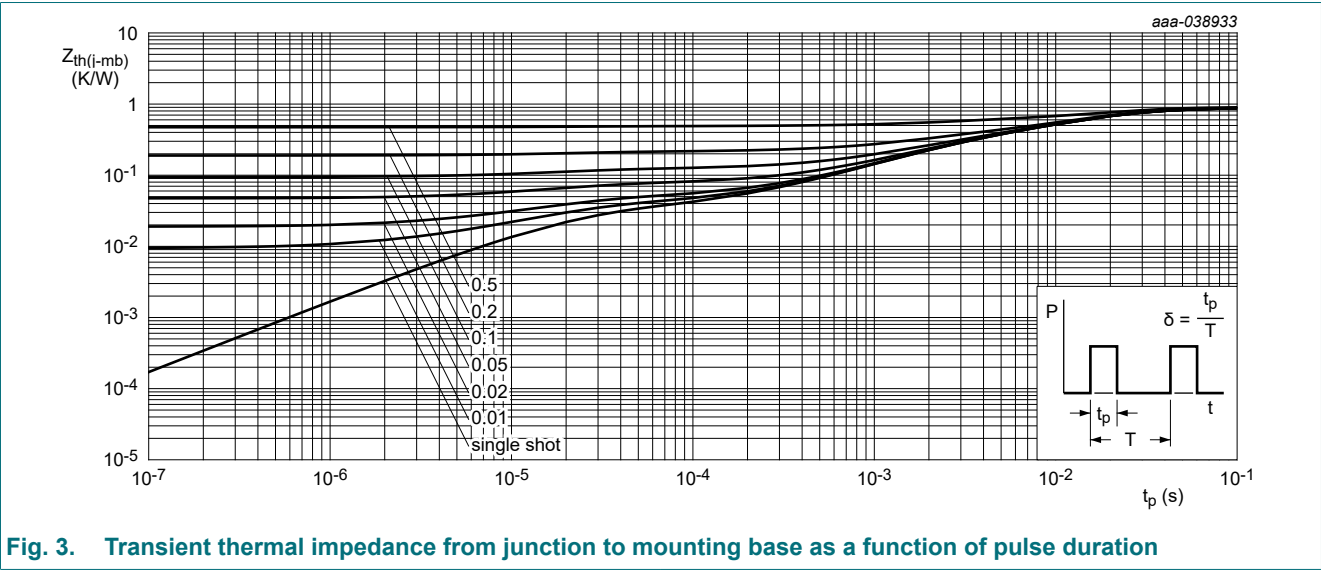


9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
$R_{th(j-c)}$	thermal resistance from junction to case		[1]	-	-	14.26	K/W
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	Fig. 3		-	-	0.95	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	[2]	-	-	52.12	K/W

- [1] Thermal junction to top side of package.  
[2]  $R_{th(j-a)}$  is determined with the device mounted on one square inch of copper pad single layer 2 oz copper on FR4 board.



## 10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
<b>Static characteristics</b>							
$BV_{DDs}$	drain-drain breakdown voltage	$I_{D1D2} = 500 \mu A$ ; $V_{D2} = V_G = 0 V$ ; $T_j = 25^\circ C$	[1]	40	-	-	V
$V_{GD(th)}$	gate-drain threshold voltage	$I_D = 1 mA$ ; $V_{D1} = 0 V$ ; $V_{D2} = V_G$ ; $T_j = 25^\circ C$ ; Fig. 8	[1]	0.8	1.35	2.4	V
		$I_D = 1 mA$ ; $V_{D1} = 0 V$ ; $V_{D2} = V_G$ ; $T_j = 125^\circ C$ ; Fig. 8	[1]	-	1.1	-	V
$I_{DDs}$	drain-drain leakage current	$V_{DD} = 40 V$ ; $V_{GD} = 0 V$ ; $T_j = 25^\circ C$	[1]	-	1	50	$\mu A$
$I_{GDS}$	gate-drain leakage current	$V_{GD} = 5 V$ ; $V_{DD} = 0 V$ ; $T_j = 25^\circ C$	[1]	-	0.5	5	$\mu A$
		$V_{GD} = -5 V$ ; $V_{DD} = 0 V$ ; $T_j = 25^\circ C$		-30	-	-	$\mu A$
		$V_{GD} = 6 V$ ; $V_{DD} = 0 V$ ; $T_j = 25^\circ C$	[1]	-	5	30	$\mu A$
		$V_{GD} = -6 V$ ; $V_{DD} = 0 V$ ; $T_j = 25^\circ C$		-40		-	$\mu A$
$R_{DDon}$	drain-drain on-state resistance	$V_{GD2} = 5 V$ ; $I_{D1} = 10 A$ ; $T_j = 25^\circ C$ ; Fig. 9; Fig. 10; Fig. 11	[1]	-	0.9	1.2	m $\Omega$
		$V_{GD2} = 5 V$ ; $I_{D1} = 10 A$ ; $T_j = 125^\circ C$ ; Fig. 9; Fig. 12		-	1.6	-	m $\Omega$
$R_G$	gate resistance	$f = 1 MHz$ ; $T_j = 25^\circ C$		-	8.7	-	$\Omega$
<b>Dynamic characteristics</b>							
$Q_{G(tot)}$	total gate charge	$V_{DS} = 20 V$ ; $V_{GS} = 5 V$ ; $I_D = 10 A$ ; $T_j = 25^\circ C$ ; Fig. 13; Fig. 14	[2]	-	60	-	nC
$Q_{GS}$	gate-source charge		[2]	-	6.2	-	nC
$Q_{GD}$	gate-drain charge		[2]	-	32	-	nC
$C_{iss}$	input capacitance	$V_{DS} = 20 V$ ; $V_{GS} = 0 V$ ; $f = 1 MHz$ ; $T_j = 25^\circ C$ ; Fig. 15	[2]	-	3500	-	pF
$C_{oss}$	output capacitance			-	1600	-	pF
$C_{rss}$	reverse transfer capacitance			-	1000	-	pF
$Q_{oss}$	output charge	$V_{DS} = 20 V$ ; $V_{GD} = 0 V$ ; $T_j = 25^\circ C$ ; Fig. 7	[2][3]	-	45	-	nC

- [1] Parameters are understood to apply for either polarity of bias. For example,  $V_{DD}$  is the same whether D1 is the source and D2 is the drain or vice versa.
- [2] D1 and D2 are symmetrical with respect to the gate, G. Either can take the function of source or drain. For data sheet parameters, the source is defined as the terminal, D1 or D2, which has lower potential in the test circuit. The drain is the terminal with the higher potential.
- [3]  $Q_r$  is not specified separately from  $Q_{oss}$  for e-mode GaN FETs, since  $Q_r = Q_{oss} + Q_D$ , and  $Q_D = 0$ . ( $Q_D$  is charge associated with diffusion of minority carriers. Since there is no body diode, no minority carriers in excess of  $Q_{oss}$  have to be transferred for e-mode GaN FETs.)

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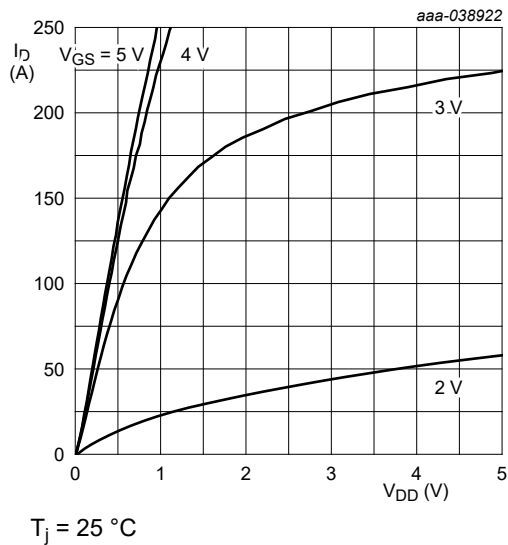


Fig. 4. Output characteristics; drain current as a function of drain-drain voltage; typical values

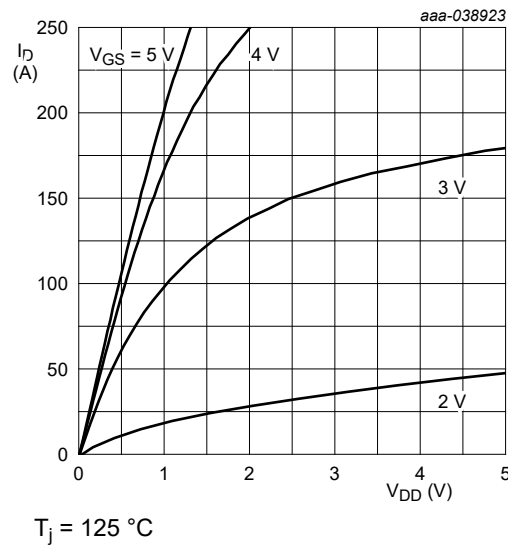


Fig. 5. Output characteristics; drain current as a function of drain-drain voltage; typical values

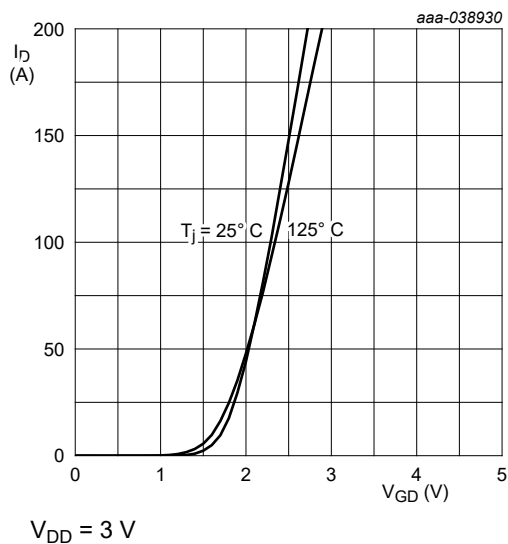


Fig. 6. Transfer characteristics; drain current as a function of gate-drain voltage; typical values

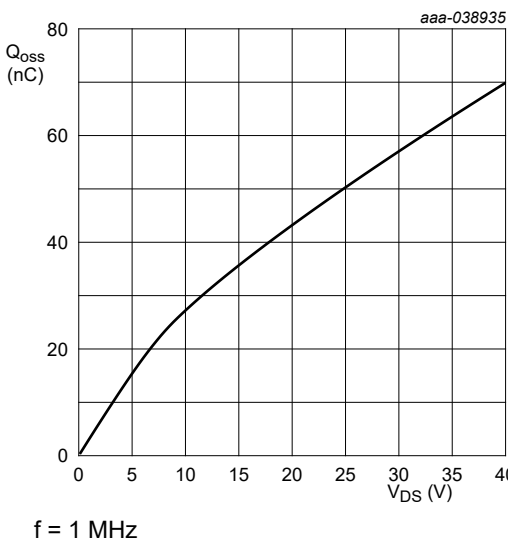
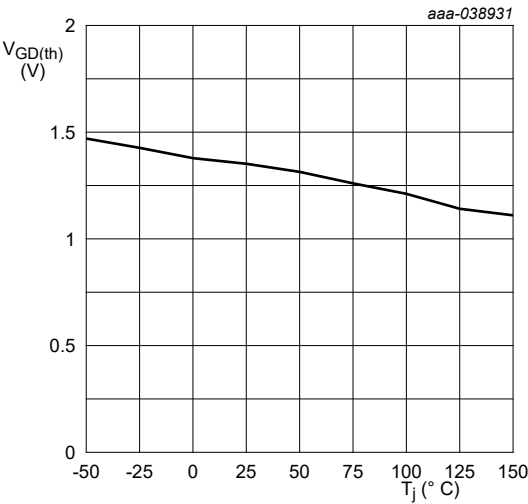


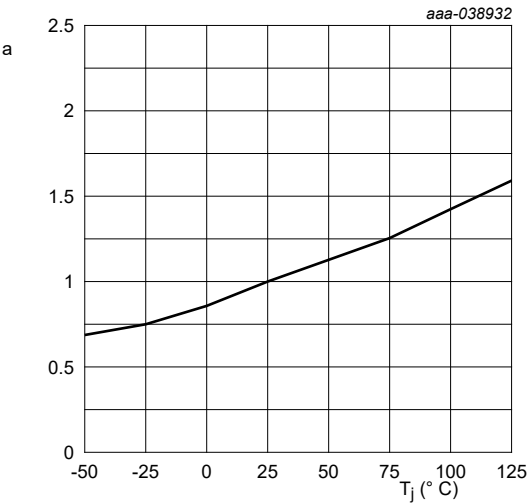
Fig. 7. Output charge as a function of drain-source voltage; typical values

40 V, 1.2 mOhm bi-directional Gallium Nitride (GaN) FET in a 4.0 mm x 6.0 mm Very-Thin-Profile Quad Flat No-Lead Package (VQFN)



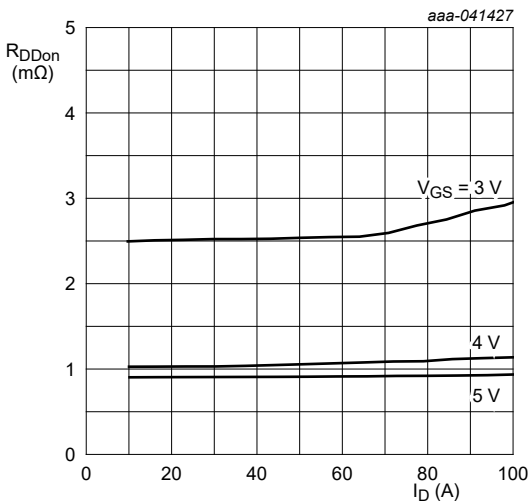
$I_D = 1\text{ mA}$  ;  $V_{DD} = V_{GD}$

Fig. 8. Gate-drain threshold voltage as a function of junction temperature; typical values



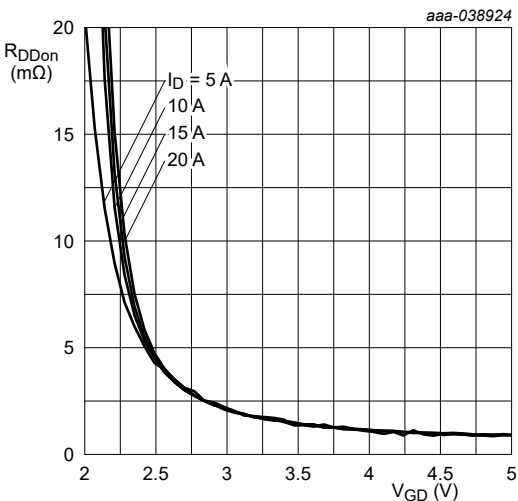
$$a = \frac{R_{DDon}}{R_{DDon}(25^\circ\text{C})}$$

Fig. 9. Normalized drain-drain on-state resistance factor as a function of junction temperature; typical values



$T_j = 25\text{ }^\circ\text{C}$

Fig. 10. Drain-drain on-state resistance as a function of drain current; typical values



$T_j = 25\text{ }^\circ\text{C}$

Fig. 11. Drain-drain on-state resistance as a function of gate-drain voltage; typical values

40 V, 1.2 mOhm bi-directional Gallium Nitride (GaN) FET in a 4.0 mm x 6.0 mm Very-Thin-Profile Quad Flat No-Lead Package (VQFN)

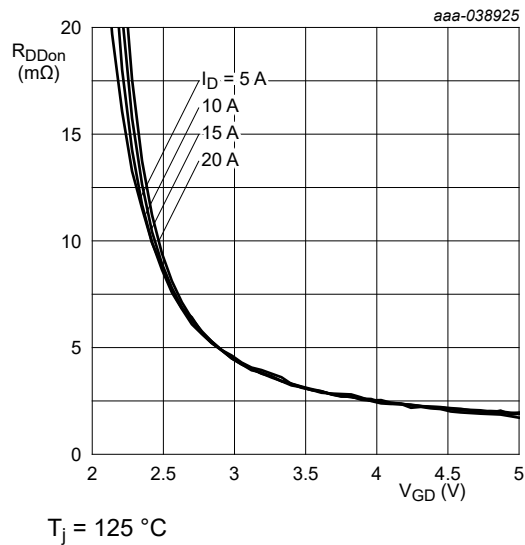


Fig. 12. Drain-drain on-state resistance as a function of gate-drain voltage; typical values

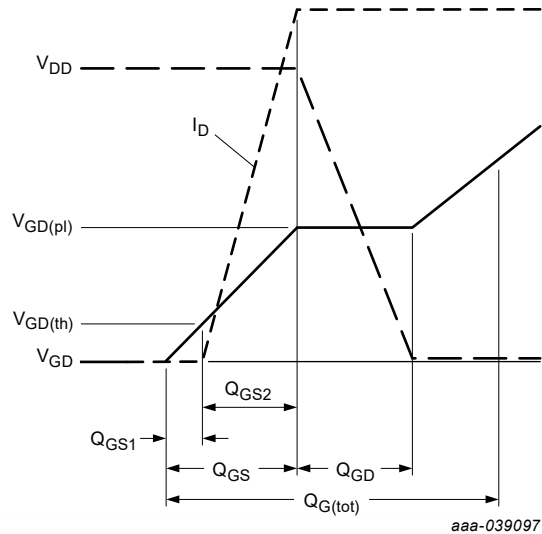


Fig. 13. Gate charge waveform definitions

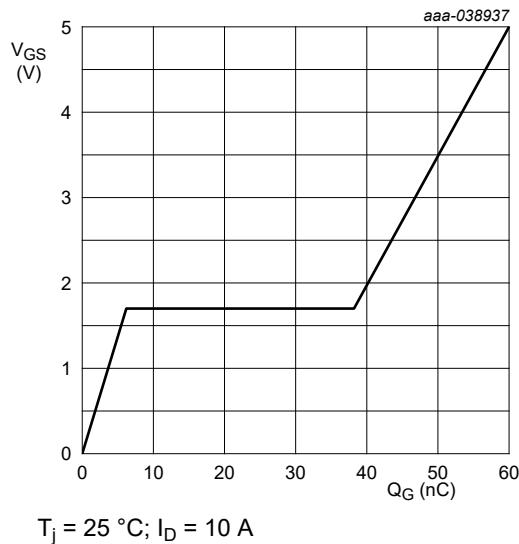


Fig. 14. Gate-source voltage as a function of gate charge; typical values

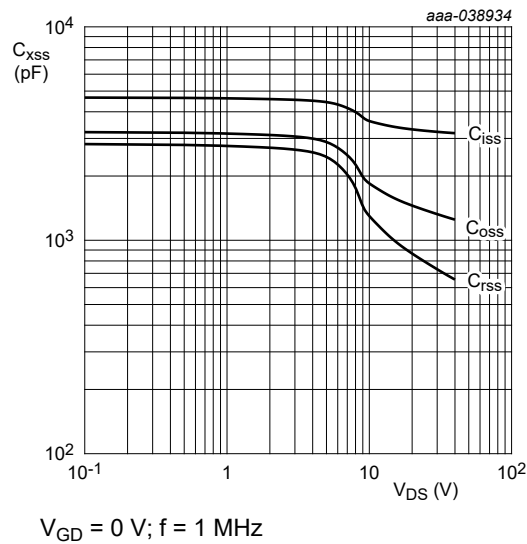


Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



40 V, 1.2 mOhm bi-directional Gallium Nitride (GaN) FET in a 4.0 mm x 6.0 mm Very-Thin-Profile Quad Flat No-Lead Package (VQFN)

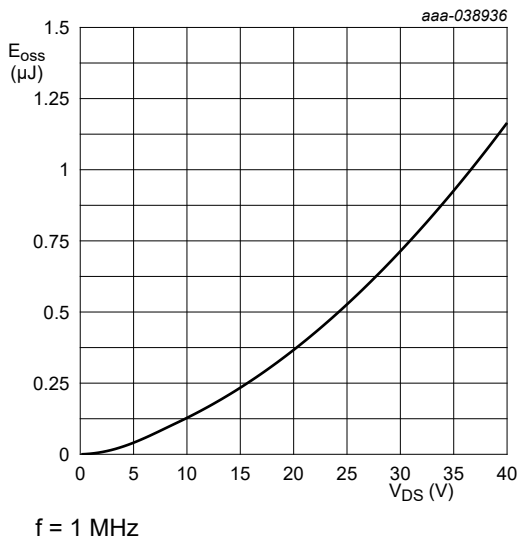


Fig. 16.  $C_{oss}$  stored energy as a function of drain-source voltage; typical values

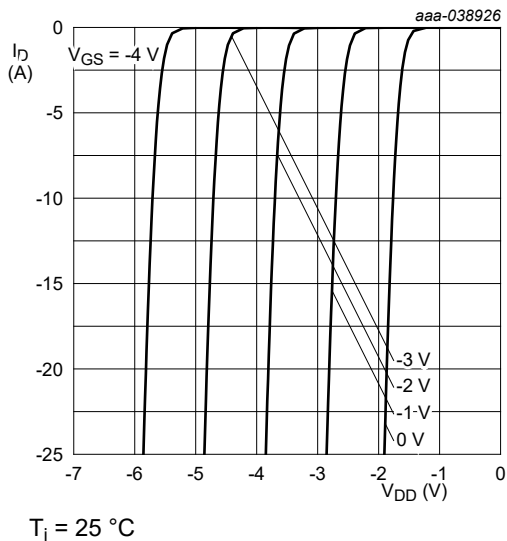


Fig. 17. Reverse drain current as a function of drain-drain voltage; typical values

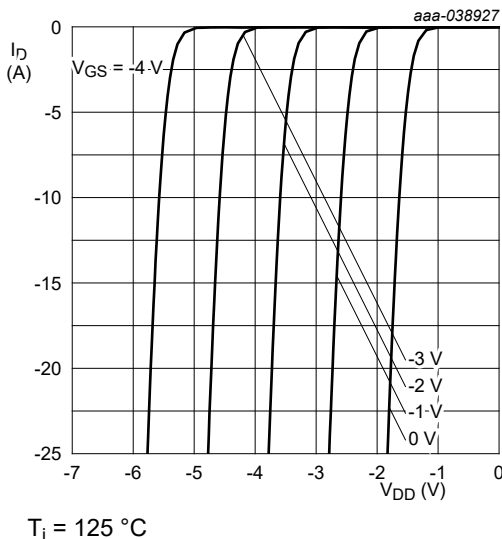


Fig. 18. Reverse drain current as a function of drain-drain voltage; typical values

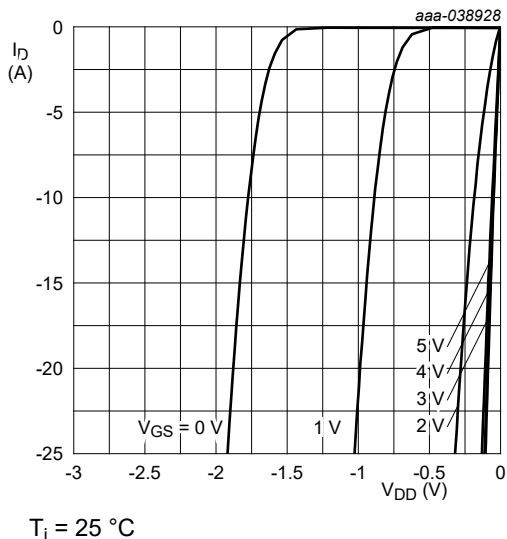
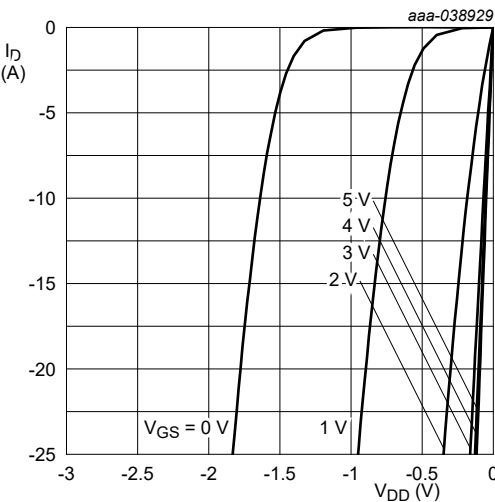


Fig. 19. Reverse drain current as a function of drain-drain voltage; typical values

40 V, 1.2 mOhm bi-directional Gallium Nitride (GaN) FET in a 4.0 mm x 6.0 mm Very-Thin-Profile Quad Flat No-Lead Package (VQFN)



$T_j = 125\text{ °C}$

Fig. 20. Reverse drain current as a function of drain-drain voltage; typical values

11. Package outline

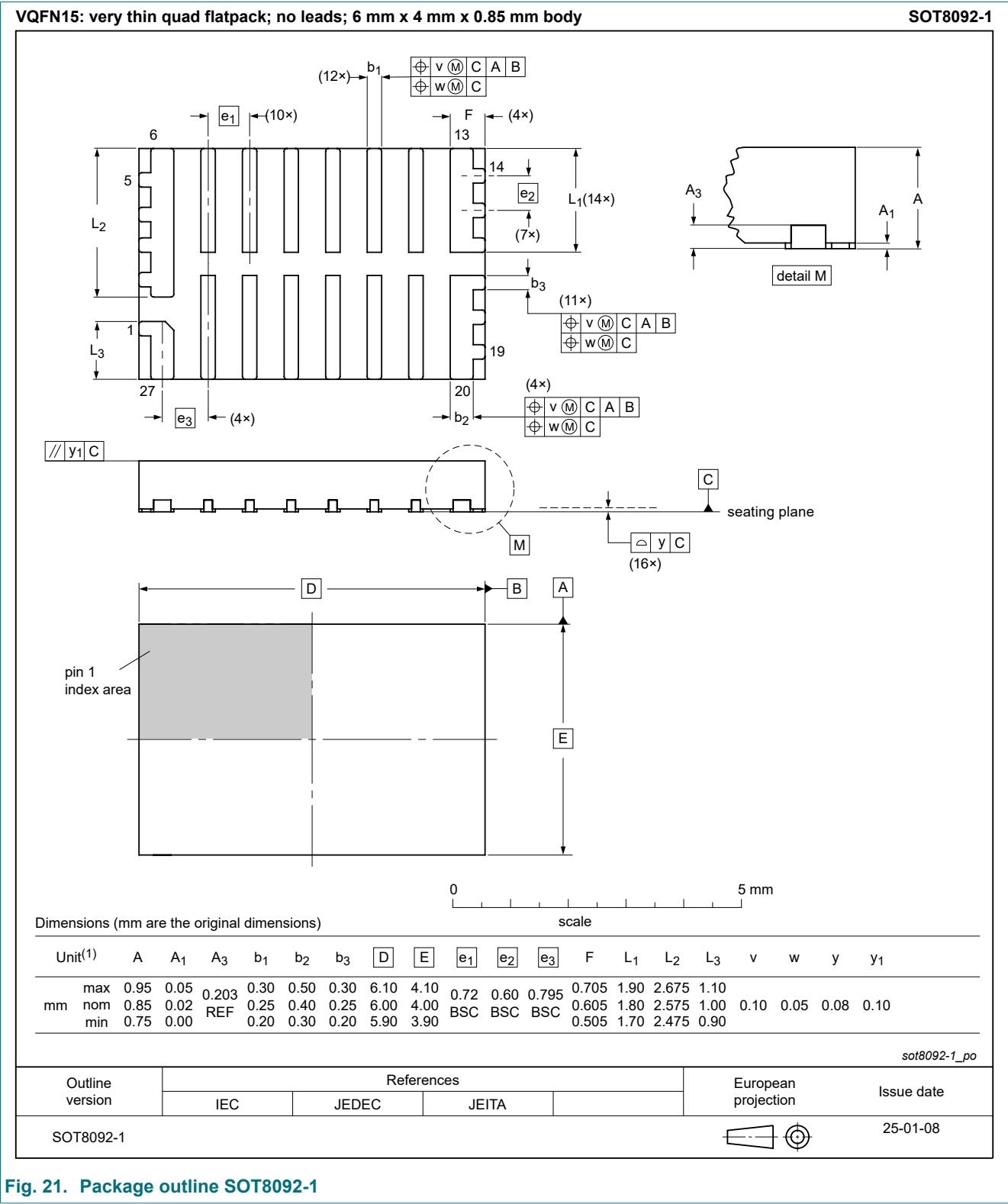


Fig. 21. Package outline SOT8092-1

12. Soldering

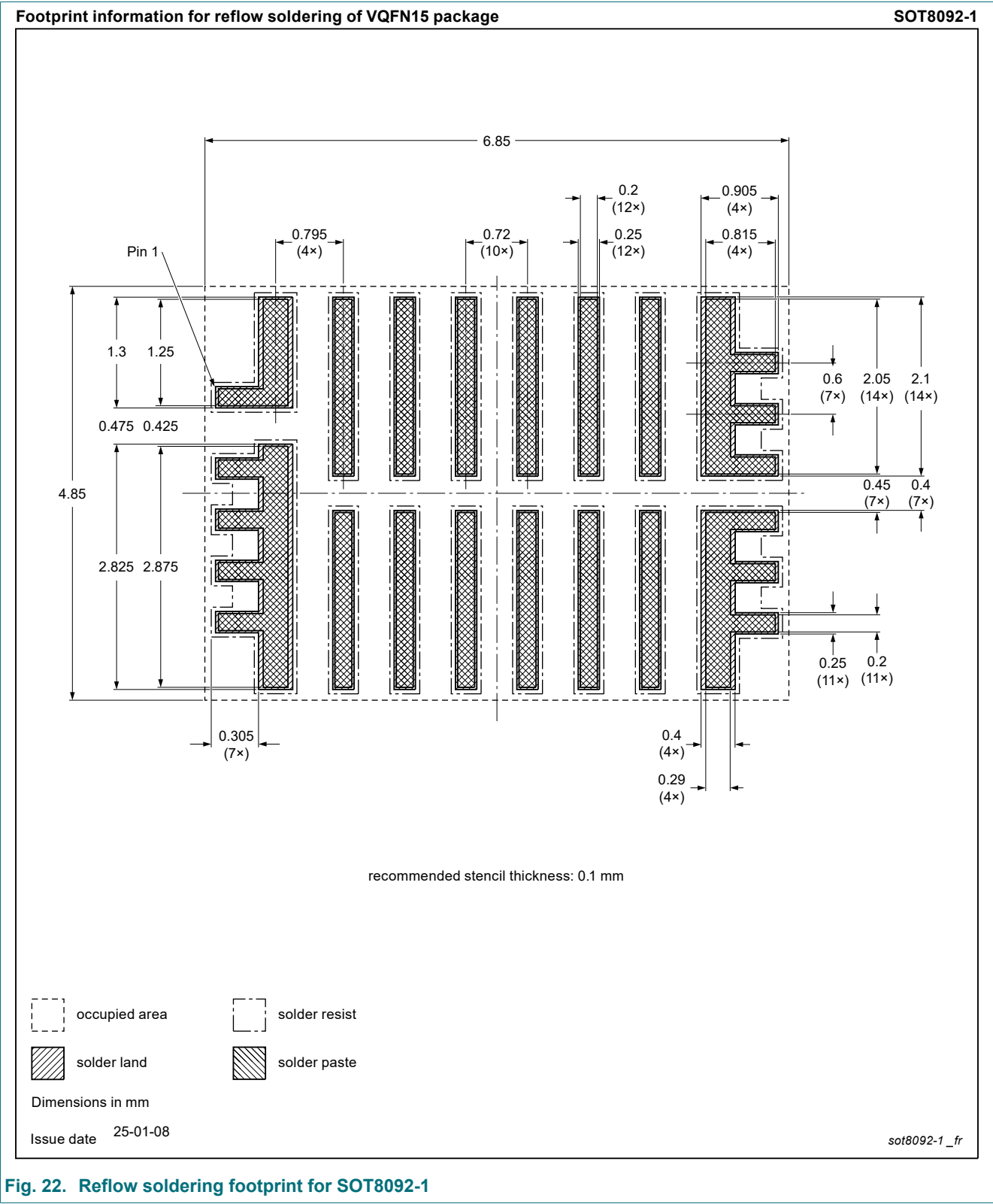


Fig. 22. Reflow soldering footprint for SOT8092-1

40 V, 1.2 mOhm bi-directional Gallium Nitride (GaN) FET in a 4.0 mm x 6.0 mm Very-Thin-Profile Quad Flat No-Lead Package (VQFN)

13. Legal information

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Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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Contents

1. General description..... 1

2. Features and benefits..... 1

3. Applications..... 1

4. Quick reference data..... 1

5. Pinning information.....2

6. Ordering information.....2

7. Marking..... 2

8. Limiting values..... 3

9. Thermal characteristics..... 4

10. Characteristics..... 5

11. Package outline..... 11

12. Soldering..... 12

13. Legal information.....13

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